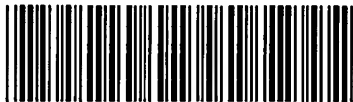


**Search Notes**

Application/Control No.

10/541,071

Examiner

Ellen Kim

Applicant(s)/Patent under  
Reexamination

FACCIO ET AL.

Art Unit

2874

**SEARCHED**

Class	Subclass	Date	Examiner
385	14,27	1/22/2007	EK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	1/22/2007	EK